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Substitut	e for form 1449A/PTC)		Complete If Known			
	_			Application Number	09/658,771		
INFC	PRMATION	DIS	CLOSURE	Filing Date	September 11, 2000		
STATEMENT BY APPLICANT				First Named Inventor	YARLAGADDA, MADHU		
				Group Art Unit	2744		
(use as many sheets as necessary)				Examiner Name	Unassigned		
Sheet	1	of	1	Attorney Docket Number	017887-006000US		

			U.S. PATENT DOCUI	MENTS	<u>· </u>	
Examiner Initials *	Cite No.'	U.S. Palent Document Number Kind Code ² (If known)	Name of Patentee or Applicant of Cited Document	Data of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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FORM PTO-144	19 (Modified)		Attorney Docket No.: 17887-006000US Application No.: 09/658,771					
LIST OF PATE	NTS AND PUBL	ICATIONS FOR	Applicant: YARLAGADDA et al.					
	INFORMATION Use several sheets		Filing Date: September 11, 2000 Group: 2744					
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